

## SIL DECLARATION OF CONFORMITY Model ST100 SERIES

We, *Fluid Components International LLC,* located at 1755 La Costa Meadows Drive, San Marcos, California 92078-5115 USA, declare as manufacturer, that the *ST100 Series* of products is suitable for use in a safety instrumented system for SIL 1, flow, temperature and pressure measurement.

The ST100 Series has been classified as Type B subsystem according to IEC 61508-1 Chapter 7.4.4.1.3 with a Hardware tolerance (HFT) of 0.

The Failure Modes, Effects and Diagnostic Analysis (FMEDA) report carried out by *exida*, resulted in following failure ratings:

SIL (Safety Integrity Level) : 1 - As a single device

HFT (Hardware Fault Tolerance) : 0
Subsystem type : B

Failure rates according to IEC 61508-1

Function	SFF	PFD (AVG)	λ <sub>DU</sub>	$\lambda_{DD}$	λ <sub>SU</sub>	$\lambda_{SD}$
Single Probe AC supply	79.8 %	1.21 x 10 <sup>-2</sup>	567 FIT	1927 FIT	314 FIT	0
Single Probe DC supply	79.9 %	1.22 x 10 <sup>-2</sup>	570 FIT	1946 FIT	317 FIT	0
Dual Probe AC supply	88.9%	1.00 x 10 <sup>-2</sup>	415 FIT	2918 FIT	404 FIT	0
Dual Probe DC supply	88.9%	1.01 x 10 <sup>-2</sup>	418 FIT	2937 FIT	407 FIT	0

## Terminology:

SFF = Safe Failure fraction

PFD = Probability of failure on demand

 $\lambda_{DU}$  = failure rate dangerous undetected faults

 $\lambda_{DD}$ = failure rate dangerous detected faults

 $\lambda_{SU}$  = failure rate safe undetected faults

 $\lambda_{SD}$  = failure rate safe detected faults

FIT = Failure Rate in 10-9 /hour

## Above analysis is based on assuming:

- The HART protocol is used for setup, calibration and diagnostics purposes, not for safety critical function.
- Materials are compatible with process conditions.
- The device is installed per manufacturer's instructions.
- External power supply failure rates are not included.
- Worst-case internal fault detection time is 1 hour.
- The device is configured for fault detection per NAMUR NE43 or the logic solver is configured to interpret
  output fault conditions.
- Proof test interval of 1 year.

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